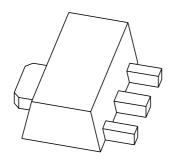
# **DISCRETE SEMICONDUCTORS**

# DATA SHEET



PBSS4540X 40 V, 5 A NPN low V<sub>CEsat</sub> (BISS) transistor

Product data sheet Supersedes data of 2004 Jun 11 2004 Nov 04



# 40 V, 5 A NPN low V<sub>CEsat</sub> (BISS) transistor

# PBSS4540X

### **FEATURES**

- High hFE and low VCEsat at high current operation
- High collector current capability: I<sub>C</sub> maximum 4 A
- · High efficiency leading to less heat generation.

## **APPLICATIONS**

- Medium power peripheral drivers (e.g. fan and motor)
- Strobe flash units for DSC and mobile phones
- Inverter applications (e.g. TFT displays)
- · Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- · Battery chargers.

### **DESCRIPTION**

NPN low V<sub>CEsat</sub> transistor in a medium power SOT89 (SC-62) package.

PNP complement: PBSS5540X.

## **MARKING**

TYPE NUMBER	MARKING CODE <sup>(1)</sup>
PBSS4540X	*1B

## Note

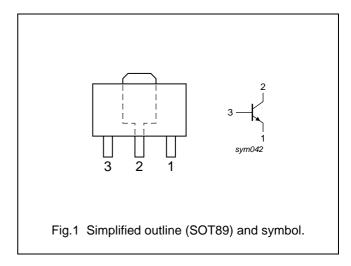
- 1. \* = p: made in Hong Kong.
  - \* = t: made in Malaysia.
  - \* = W: made in China.

## **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	40	V
I <sub>C</sub>	collector current (DC)	4	Α
I <sub>CM</sub>	peak collector current	10	Α
R <sub>CEsat</sub>	equivalent on-resistance	71	mΩ

## **PINNING**

PIN	DESCRIPTION
1	emitter
2	collector
3	base



## **ORDERING INFORMATION**

TYPE NUMBER	PACKAGE			
TIFE NOMBER	NAME DESCRIPTION VER			
PBSS4540X	SC-62	SC-62 plastic surface mounted package; collector pad for good heat transfer; 3 leads		

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### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

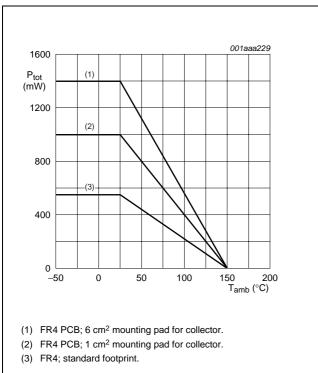
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	-	40	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	40	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	6	V
I <sub>C</sub>	collector current (DC)		-	4	Α
I <sub>CRM</sub>	maximum repetitive collector current	notes 1 and 2	-	5	Α
I <sub>CM</sub>	peak collector current	$t_p \le 1 \text{ ms}$	-	10	Α
I <sub>B</sub>	base current (DC)		-	1	Α
I <sub>BM</sub>	peak base current	$t_p \le 1 \text{ ms}$	_	2	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C			
		notes 1 and 2	_	2.5	W
		note 2	_	0.55	W
		note 3	_	1	W
		note 4	_	1.4	W
		note 5	_	1.6	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		-	150	°C
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C

## **Notes**

- 1. Operated under pulsed conditions; pulse width  $t_p \le 10$  ms; duty cycle  $\delta \le 0.2$ .
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm<sup>2</sup>.
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm<sup>2</sup>.
- 5. Device mounted on a 7 cm<sup>2</sup> ceramic printed-circuit board, 1 cm<sup>2</sup> single-sided copper and tin-plated. For other mounting conditions, see *"Thermal considerations for SOT89 in the General Part of associated Handbook"*.

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- Fig.2 Power derating curves.

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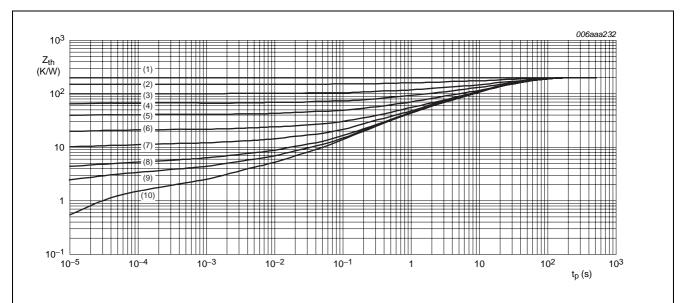
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### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th(j-a)</sub>	from junction to ambient	in free air		
		notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R <sub>th(j-s)</sub>	from junction to soldering point		16	K/W

### **Notes**

- Operated under pulsed conditions; pulse width  $t_p \le 10$  ms; duty cycle  $\delta \le 0.2$ .
- Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint. 2.
- Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm<sup>2</sup>. 3.
- Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm<sup>2</sup>. 4.
- Device mounted on a 7 cm<sup>2</sup> ceramic printed-circuit board, 1 cm<sup>2</sup> single-sided copper and tin-plated. For other mounting conditions, see "Thermal considerations for SOT89 in the General Part of associated Handbook".



Mounted on FR4 printed-circuit board; standard footprint.

- (1)  $\delta = 1$ .
- (3)  $\delta = 0.5$ .
- (5)  $\delta = 0.2$ .
- (7)  $\delta = 0.05$ .
- (9)  $\delta = 0.01$ .

- (2)  $\delta = 0.75$ .
- (4)  $\delta = 0.33$ .
- (6)  $\delta = 0.1$ .
- (8)  $\delta = 0.02$ .
- (10)  $\delta = 0$ .

Fig.3 Transient thermal impedance as a function of pulse time; typical values.

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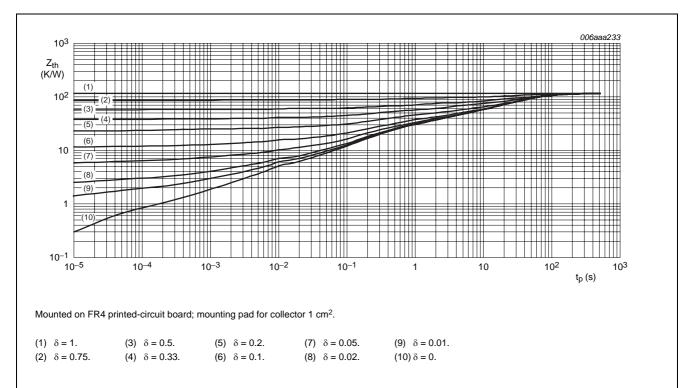
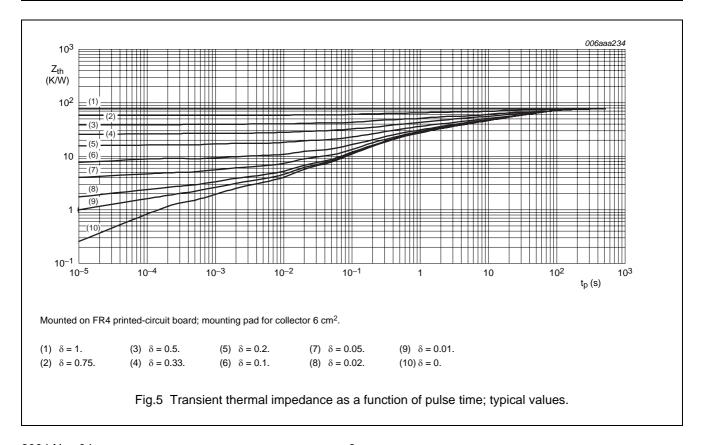


Fig.4 Transient thermal impedance as a function of pulse time; typical values.



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## **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

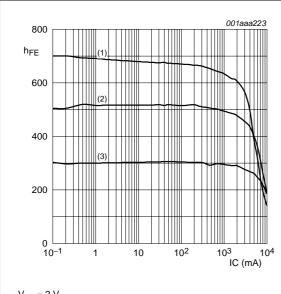
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off	V <sub>CB</sub> = 30 V; I <sub>E</sub> = 0 A	_	_	100	nA
	current	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	_	_	50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	V <sub>CE</sub> = 30 V; V <sub>BE</sub> = 0 V	_	-	0.1	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	V <sub>EB</sub> = 5 V; I <sub>C</sub> = 0 A	_	_	100	nA
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 2 V; I <sub>C</sub> = 0.5 A	300	_	_	
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 1 A; note 1	300	_	_	
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 2 A; note 1	250	_	_	
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 5 A; note 1	100	_	_	
V <sub>CEsat</sub>		$I_C = 0.5 \text{ A}; I_B = 5 \text{ mA}$	_	_	90	mV
voltage	voltage	I <sub>C</sub> = 1 A; I <sub>B</sub> = 10 mA	_	_	120	mV
		I <sub>C</sub> = 2 A; I <sub>B</sub> = 200 mA; note 1	_	_	150	mV
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 200 mA; note 1	_	_	290	mV
		I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; note 1	_	_	355	mV
R <sub>CEsat</sub>	equivalent on-resistance	I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; note 1	_	40	71	mΩ
V <sub>BEsat</sub>	base-emitter saturation	I <sub>C</sub> = 4 A; I <sub>B</sub> = 200 mA; note 1	_	_	1.1	٧
	voltage	I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; note 1	_	_	1.2	٧
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	_	-	1.1	V
f <sub>T</sub>	transition frequency	V <sub>CE</sub> = 10 V; I <sub>C</sub> = 0.1 A; f = 100 MHz	70	-	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	_	_	75	pF

## Note

1. Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

# 40 V, 5 A NPN low V<sub>CEsat</sub> (BISS) transistor

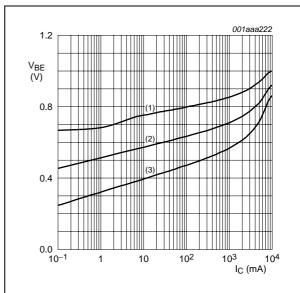
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 $V_{CE} = 2 V$ .

- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

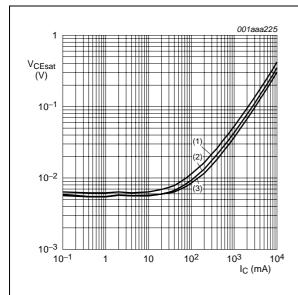
Fig.6 DC current gain as a function of collector current; typical values.



 $V_{CE} = 2 V.$ 

- (1) T<sub>amb</sub> = 55 °C.
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 100 \, ^{\circ}C$ .

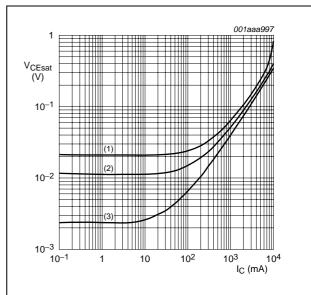
Fig.7 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1) T<sub>amb</sub> = 100 °C.
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$ .
- (3)  $I_C/I_B = 10$ .

Fig.9 Collector-emitter saturation voltage as a function of collector current; typical values.

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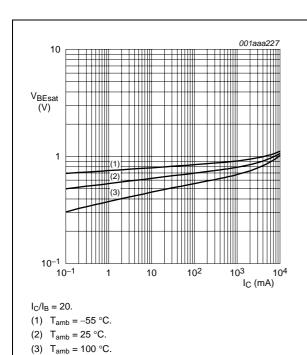


Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.

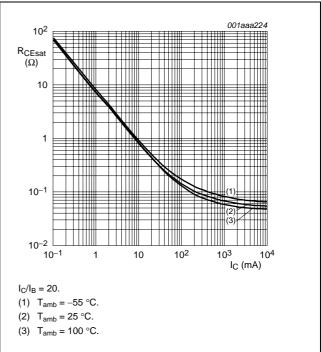
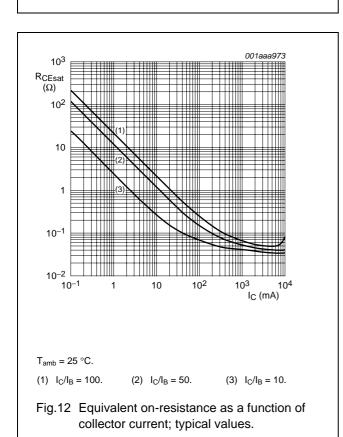
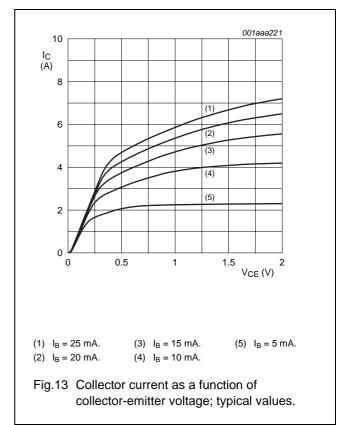


Fig.11 Equivalent on-resistance as a function of collector current; typical values.

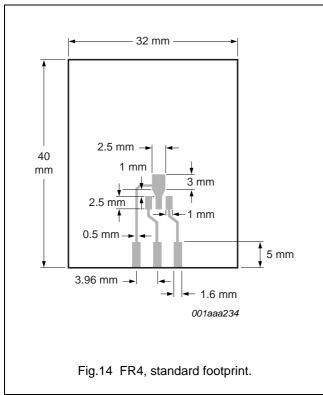


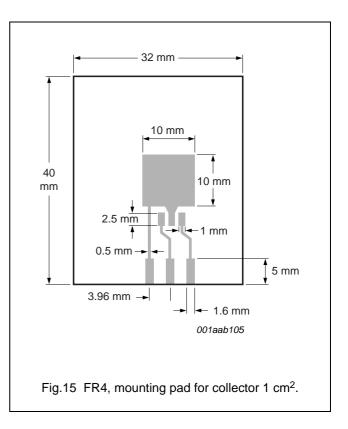


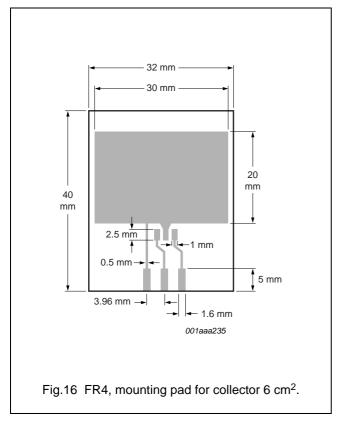
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## Reference mounting conditions







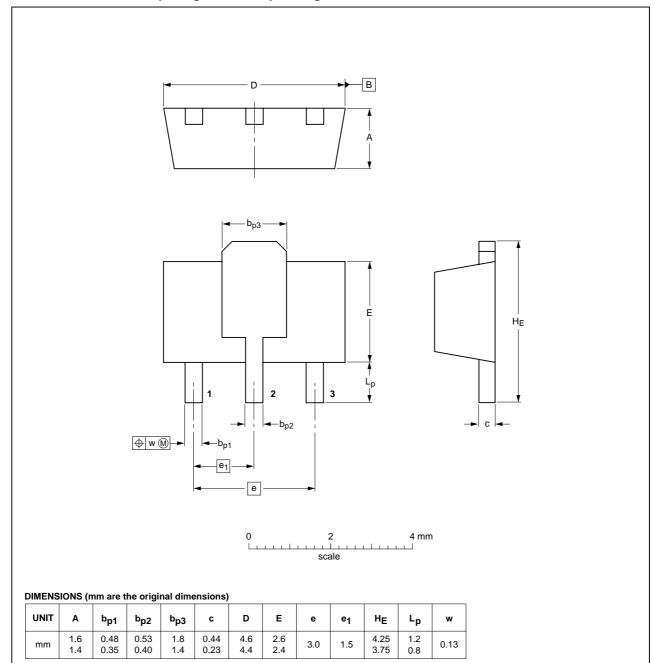
# 40 V, 5 A NPN low V<sub>CEsat</sub> (BISS) transistor

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## **PACKAGE OUTLINE**

## Plastic surface-mounted package; collector pad for good heat transfer; 3 leads

SOT89



OUTLINE	OUTLINE REFERENCES		EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT89		TO-243	SC-62			<del>04-08-03</del> 06-03-16

# 40 V, 5 A NPN low V<sub>CEsat</sub> (BISS) transistor

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### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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